Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10578994	GRONAU ET AL.
Examiner	Art Unit
Hau V Phan	3618

SEARCHED					
Class	Subclass	Date	Examiner		
180	169, 168, 170, 171	8/28/2008	HP		
701	30, 96, 208, 51, 54	8/28/2008	HP		
477	107, 108, 34	8/28/2008	HP		

SEARCH NOTES		
Search Notes	Date	Examiner
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INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/Hau V Phan/ Primary Examiner.Art Unit 3618

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